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Form PTO-1449 US Dept. of Commerce (REV. 8-83) PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT			ATTY DOCKET NO. 118520				APPLICATION NO. New U.S. Patent Application		
(Use several sheets if necessary)					APPLICANTS Tokio OOI et al.				
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		DOCUMENT NUMBER	r	DATE		COUNTRY		CLASS	SUB CLASS
/SH/	1	JP A 2000-313611 w/ abst & trans	11/1	4/2000	Japan				
/SH/	2	JP A 63-030308 w/ abst	02/0	9/1988	Japan				
/SH/	3.	JP B2 1-52324 w/ abst	01/0	7/1983	Japan				•
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Examiner:

Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: February 5, 2004

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Form PTO-1 449 US Dept. of Commerce (REV. 1/06) PATENT & TRADEMARK OFFICE		ormerce OFFICE	ATTY DOCKET NO. 118520				APPLICATION NO. 10/771,380				
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/SH/	1	JP A 06-100309	4/12/199	4	Japan			х	.x		
/SH/	2	JP A 09-183605	7/15/199	7	Japan			х	х		
/SH/	3	JP A 61-191510	8/26/198	6	Japan			х			
/SH/	4	JP A 62-132543	6/15/198	7	Japan			х			
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Form PTO-14 (REV. 1/06)	149 777	US Dept. of Co		ATTY 118520	DOCKET NO.		APPLICAT 10/771,380			
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/SH/	4	EP 0 557 208 A1	08/25/1993		EUROPE					
/SH/	5	WO 01/52981 A1	07/26/2001		WIPO		х			
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Initials	No.									
/SH/	6	Moore, S.V., et al. "The Preparation of Carbon Molecular Sieves by Pore Blocking." Carbon, Vol. 15, pp. 177 - 180, (1977).								
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/SH/		Method." Carbon, Vol. 34, No. 2								
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Date: October 10, 2006